Chip Scale Review

2019 Editorial Calendar

(Editorial close date: 12/1/2018	January • February	Industry Events	
5G developments		APEX Expo San Diego, CA (Jan 26-31) 3D & Systems Summit Dresden, Germany (Jan 28-30) SMTA Pan Pac Microelectronics Symposium Kauai, Hawaii (Feb 11-14) FLEX / MEMS & Sensors Technical Congress Monterey, CA (Feb 18-21)	
Stretchable interconnects			
Low-temp direct bond interconnect			
Thermal debonding and warpage in FOWLP			
Transfer molding for FOWLP			
TSV and RDL technologies			
3D IC metrology			
Discontinuities drive data integration			
Innovative materials & processes			
Next-gen large die WLCSP structure			

Ad Space Close Jan 18 - Ad Materials Close Jan 25

(Editorial close date: 1/15/19)	March • April	Industry Events		
SiP technology, drivers & market trends		TestConX Mesa, AZ (March 3-6) IMAPS Device Packaging Fountain Hills, AZ (March 4-7) SEMICON China Shanghai, China (March 20-22) ISS Europe Milan, Italy (March 31-April 2)		
3D system packaging				
Thin wafer handling				
High yield solutions for FOWLP				
Solders in semiconductor device assembly		,, (, ,		
Hi-reliability standards				
MEMS sensors				
Innovative microelectronic solutions				
OSAT new & emerging package offerings				

Ad Space Close Mar 13 - Materials Close Mar 22

		Au Space Close Mai 13 - Materials Close Mai 22
(Editorial close date: 3/8)	May • June	Industry Events
Al in packaging		SEMICON SE Asia Kuala Lumpur, Malaysia (May 7-9)
Heterogeneous integration		• ECTC Las Vegas, NV (May 28-31)
Multi-die/ substrate heterogeneous packages		• IEEE/SW Test Workshop (SWTW) San Diego, CA (June 2-5)
Reliability		• Sensors Expo San Jose, CA (June 25-27)
Automotive		• SEMICON West San Francisco, CA (July 9-11)
Inspection for advanced packaging processes		
RF, Final test		
Advances in wafer probe		
Smart devices and applications		